Notice of References Cited Application/Control No. 10/044,325 Examiner Ricardo Pizarro Applicant(s)/Patent Under Reexamination IYER ET AL. Art Unit Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2004/0202171	10-2004	Hama, Daisuke	370/395.1
	В	US-6,873,602	03-2005	Ambe, Michiko	370/254
	С	US-2003/0118036	06-2003	Gibson et al.	370/401
	D	US-2003/0061338	03-2003	STELLIGA, TONY	709/224
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	К	US-			
	L	US-			
. :	·M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
;	0					
	Р					
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	x	• .

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